

July 1994 Revised February 2005

74VHC27 Triple 3-Input NOR Gate

General Description

The VHC27 is an advanced high speed CMOS 3-Input NOR Gate fabricated with silicon gate CMOS technology. It achieves the high-speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which provide high noise immunity and stable output. An input protection circuit insures that 0V to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery backup. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

- High speed: $t_{PD} = 4.1 \text{ ns (typ)}$ at $T_A = 25 ^{\circ}\text{C}$
- \blacksquare Low power dissipation: I_{CC} = 2 μA (max) at T_A = 25 $^{\circ}C$
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Power down protection is provided on all inputs
- Low noise: V_{OLP} = 0.8V (max)
- Pin and function compatible with 74HC27

Ordering Code:

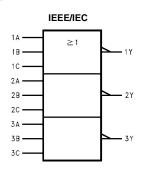
Order Number	Package Number	Package Description						
74VHC27M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow						
74VHC27MX_NL (Note 1)	M14A	Pb-Free 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow						
74VHC27SJ	M14D	Pb-Free 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide						
74VHC27MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide						
74VHC27N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide						

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Pb-Free package per JEDED J-STD-020B.

Note 1: "_NL" indicates Pb-Free package (per JEDEC J-STD-020B). Device available in Tape and Reel only.

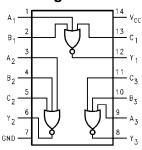
Logic Symbol



Pin Descriptions

Pin Names	Description					
A_n, B_n, C_n	Inputs					
Y _n	Outputs					

Connection Diagram



Truth Table

Α	В	С	Y
Н	Х	Х	L
Х	Н	Х	L
Х	Х	Н	L
L	L	L	Н

X = Don't Care

Absolute Maximum Ratings(Note 2)

Recommended Operating Conditions (Note 3)

 $\begin{array}{ll} {\rm DC~V_{CC}/GND~Current~(I_{CC})} & \pm 50~{\rm mA} \\ {\rm Storage~Temperature~(I_{STG})} & -65^{\circ}{\rm C~to} + 150^{\circ}{\rm C} \\ \end{array}$

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Input Rise and Fall Time (t_r, t_f)

 $V_{CC} = 3.3V \pm 0.3V$ 0 ns/V ~ 100 ns/V $V_{CC} = 5.0V \pm 0.5V$ 0 ns/V ~ 20 ns/V

Note 2: Absolute Maximum Ratings are values beyond which the device may be damaged or have its useful life impaired. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside databook specifications.

Note 3: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	v _{cc}	T _A = 25°C			$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$		Units	Conditions	
		(V)	Min	Тур	Max	Min	Max	Units	Cond	itions
V _{IH}	HIGH Level	2.0	1.50			1.50		V		
	Input Voltage	3.0 - 5.5	0.7 V _{CC}			0.7 V _{CC}		v		
V _{IL}	LOW Level	2.0			0.50		0.50	V		
	Input Voltage	3.0 - 5.5			$0.3\mathrm{V}_{\mathrm{CC}}$		$0.3~\mathrm{V}_{\mathrm{CC}}$	v		
V _{OH}	HIGH Level	2.0	1.9	2.0		1.9			$V_{IN} = V_{IH}$	$I_{OH} = -50 \mu A$
	Output Voltage	3.0	2.9	3.0		2.9		V	or V _{IL}	
		4.5	4.4	4.5		4.4				
		3.0	2.58			2.48		V		I _{OH} = -4 mA
		4.5	3.94			3.80		v		$I_{OH} = -8 \text{ mA}$
V _{OL}	LOW Level	2.0		0.0	0.1		0.1		$V_{IN} = V_{IH}$	I _{OL} = 50 μA
	Output Voltage	3.0		0.0	0.1		0.1	V	or V _{IL}	
		4.5		0.0	0.1		0.1			
		3.0			0.36		0.44	V		I _{OL} = 4 mA
		4.5			0.36		0.44	v		$I_{OL} = 8 \text{ mA}$
I _{IN}	Input Leakage Current	0 – 5.5			±0.1		±1.0	μА	V _{IN} = 5.5V or	GND
I _{CC}	Quiescent Supply Current	5.5			2.0		20.0	μА	$V_{IN} = V_{CC}$ or C	GND

Noise Characteristics

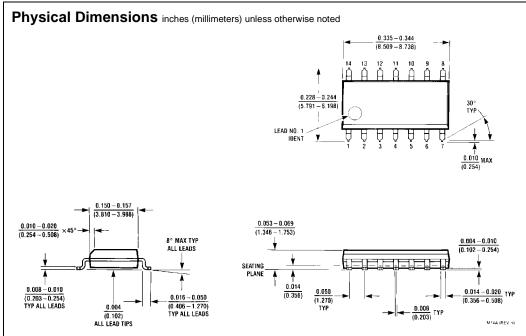
Symbol	Parameter	V _{cc}	T _A	= 25°C	Units	Conditions	
	i didilictor	(V)	Typ Limits		- Oillito	00.14.110.110	
V _{OLP}	Quiet Output Maximum	5.0	0.3	0.8	V	C _L = 50 pF	
(Note 4)	Dynamic V _{OL}						
V _{OLV}	Quiet Output Minimum	5.0	-0.3	-0.8	V	C _L = 50 pF	
(Note 4)	Dynamic V _{OL}						
V_{IHD}	Minimum HIGH Level	5.0		3.5	V	C _L = 50 pF	
(Note 4)	Dynamic Input Voltage						
V_{ILD}	Maximum LOW Level	5.0		1.5	V	C _L = 50 pF	
(Note 4)	Dynamic Input Voltage						

Note 4: Parameter guaranteed by design.

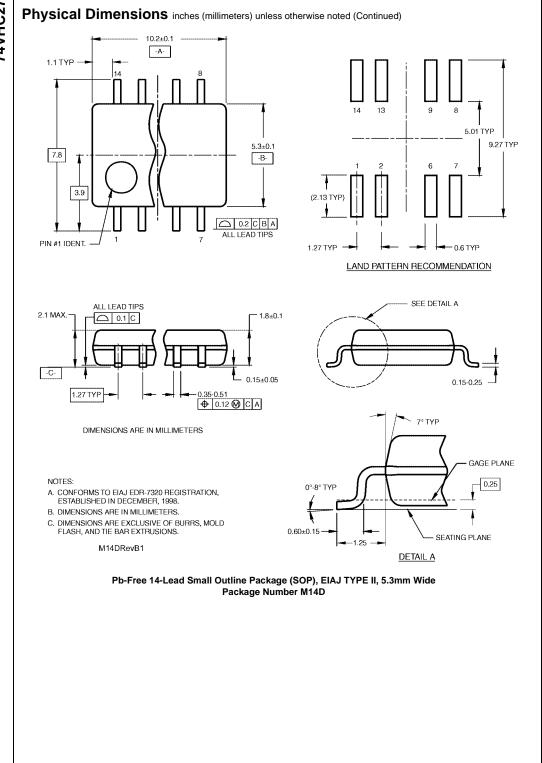
AC Electrical Characteristics

Symbol	Parameter	V _{CC}	T _A = 25°C			T _A = -40°C to +85°C		Units	Conditions
		(V)	Min	Тур	Max	Min	Max	Oille	Conditions
t _{PHL}	Propagation Delay	3.3 ± 0.3		6.2	8.8	1.0	10.5	ns	C _L = 15 pF
t_{PLH}				8.7	12.3	1.0	14.0	115	C _L = 50 pF
		5.0 ± 0.5		4.1	5.9	1.0	7.0	ns	C _L = 15 pF
				5.6	7.9	1.0	9.0	115	C _L = 50 pF
C _{IN}	Input Capacitance			4	10		10	pF	V _{CC} = Open
C _{PD}	Power Dissipation			20				pF	(Note 5)
	Capacitance								

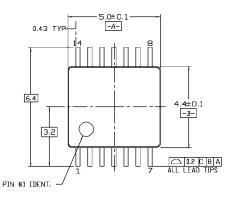
Note 5: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I_{CC} (opr.) = C_{PD} * V_{CC} * f_{IN} + I_{CC}/3 (per gate).

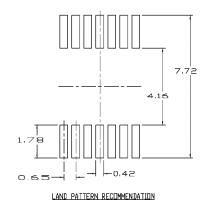


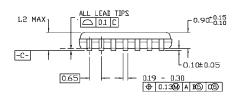
14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A

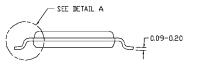


Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





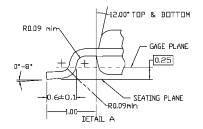




NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATED 7/93
- B. DIMENSIONS ARE IN MILLIMETERS
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS
 D. DIMENSIONING AND TOLERANCES PER ANSI Y14-5M, BY

MTC14revD



14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.770 (18.80 - 19.56)0.090 (2.286) 14 13 12 11 10 9 8 14 13 12 INDEX AREA 0.250 ± 0.010 (6.350 ± 0.254) PIN NO. 1 PIN NO. 1 IDENT 1 2 3 4 5 6 7 1 2 3 $\frac{0.092}{(2.337)}$ DIA $\frac{0.030}{(0.762)}$ MAX OPTION 1 OPTION 02 $\frac{0.135 \pm 0.005}{(3.429 \pm 0.127)}$ 0.300 - 0.320 $\frac{0.620 - 8.128}{(7.620 - 8.128)}$ 0.060 0.145 - 0.2004° TYP Optional (1.651) (3.683 - 5.080) $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 0.020 (0.508) 0.125 - 0.150 0.075 ± 0.015 $\overline{(3.175 - 3.810)}$ (1.905 ± 0.381) (7.112) MIN 0.014 - 0.0230.100 ± 0.010 (2.540 ± 0.254)

14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

 $\frac{0.050 \pm 0.010}{(1.270 - 0.254)}$ TYP

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(0.356 - 0.584)

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- 2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

0.325 ^{+0.040} -0.015 8.255 + 1.016

N144 (REV.F)

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